412th Test Wing

War-Winning Capabilities ... On Time, On Cost



Title: Parametric TLE

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Author: James Brownlow Office 812 TSS/ENTR Phone: 661 277-4843

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Preamble:

- Applying parametric survival models to analyze target location error (TLE) was the brainchild of Todd Remund, Greg Hutto, and Jeff Beekman (Beekster).
- This presentation details how the parametric survival model was adapted to TLE.
- An example is given- input file and source code in Python are available

Introduction

- Basic idea: precision target location, germane to navigation, weapon delivery and target tracking, can be related to distance from a target, as well as other possible explanatory factors (elevation and azimuth angles to the target, for example)
- Use the approach presented in Meeker and Escobar, *Statistical Reliability*, to use a generalized linear model based on log-link distribution function.
- Model fitting capabilities exist in JMP, as well as code written in Python and R

CEP

- CEP, CE10 and CE90 defined as
 - radius of a circle about the target that has the property that 50%, 10%, or 90% (respectively) of tle values are within a circle of radius 'CEP' and so forth
- Using parametric survival model, estimate CEP (or CE90, CE10) as functions of range R and associated covariates
- Additionally, we'd like confidence intervals for CE estimates, an RMS error estimate and 95/90 tolerance limits

Development

- TLE error estimates are similar to reliability of a component;
 - the cumulative probability of failure can be related to time in service
 - Similarly, cumulative probability of TLE can be related to range to the target
- Reliability (parametric) modeling provides a way to specify CEP (or CEwhatever) as a function of range to target.

Parametric Model

• Summary: generalized linear model

•
$$P(T \le \mathbf{t}_i | X) = \Phi(\frac{log(ti) - \mu_i}{\sigma_i})$$
, where
 $\mu_i = \mathbf{b}_0 + \mathbf{b}_1 X_i$ and $\sigma_i \stackrel{\sigma_i}{=} \mathbf{b}_2 + \mathbf{b}_3 X_i$

- \bullet Percentile estimates, RMS, tolerance intervals all given by Φ
- X an *n* x *m* design matrix, columns contain covariates
- Details in Meeker and Escobar, Statistical Reliability

A few details

- X is a design matrix, *n* rows, *m* columns, X(i,j) = i-th observation, explanatory variable j
- In terms of matrix algebra:
- $\mu = X\beta + \epsilon$, μ is $n \times 1$, X is $n \times m$, β is $m \times 1$, and ϵ is $n \times 1$ similarly for σ
- Estimates of $\pmb{\beta}$ found by maximum likelihood
- Log link functions:

Log Error	Link Distribution		
Log normal	normal		
Extreme value	Weibull		
log-logistic	logistic		

Log Link Models

- Innovation from the reliability model: log-link models
 - Fit log-error using MLE and a 'log error' distribution from previous slide
 - Example: log(TLE) ~ gumble(location, scale), then TLE ~ Weibull(location, scale)

Link Equations

- The key is the link between the distribution of the log of a random variable and the distribution of the random variable;
 - Y~ Weibull, then log(Y) ~ gumbel (EVS)
 - Y ~ Normal, then log(Y) ~ lognormal
 - Y ~ Logistic, then log(Y) ~ loglogistic
- Fit a generalized linear model to the log(Y)- in the 'normal' case:

$$P(\log(Y) < y) = \Phi_{ln}^{-1}\left(\frac{y-\mu_r}{\sigma_r}\right),$$

 μ_r , and σ_r functions of range

Normal-lognormal case

For Φ_{ln} , the log normal distribution function,

 $\Pr(Y \le y) = F(y; \mu, \sigma) = F(y; \beta_0, \beta_1, \sigma) = \Phi_{\ln}((y - \mu) / \sigma)$

The quantile function for this model is

$$y_p(r) = \mu + \Phi_{\ln}^{-1}(p)\sigma = \beta_0 + \beta_1 r + \Phi_{\ln}^{-1}(p)\sigma$$

The quantile function then gives us probability curves for TLE, just select 'p'

Estimation of parameters, β_0 , β_1 , and σ is based on the likelihood function

likelihood(
$$\beta_0, \beta_1, \sigma$$
) = $\prod_{i=1}^n \frac{1}{\sigma} \phi(\frac{y_i - \mu_i}{\sigma})$

Upshot..

- Parametric modeling, if appropriate is better than laboring to get IID errors
- Drawback- modeling assumes each realization (data run) is representative of a stationary, ergodic process
- Better approach may be a hierarchical model

Example: Original data



Weibull distribution



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